Search Notes

Application/Cont	Control No. Applicant(s)/Patent under Reexamination		
10/668,374		KIM, BYOU	ING-HAN
Examiner		Art Unit	
Prabodh M. Dha	ria	2629	

SEARCHED					
Class	Subclass	Date	Examiner		
345	1.1,4,5,87, 97,103, 117,	8/31/2006	PD		
345	108-111				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
East text search (US-PGPUB; UDPAT; JPO; EPO: DERWEN; IBM_TDB)	8/31/2006	PD			